Vishay Siliconix

# N-Channel 200-V (D-S) 175 °C MOSFET

PRODUCT SUMMARY				
V <sub>(BR)DSS</sub> (V)	r <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A)	Q <sub>g</sub> (Typ)	
200	0.059 at V <sub>GS</sub> = 15 V	33	53	
	0.060 at V <sub>GS</sub> = 10 V	33	55	

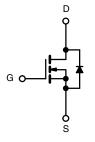
### **FEATURES**

- TrenchFET® Power MOSFETS
- 150 °C Junction Temperature
- 100 % UIS and  $R_g$  Tested



### **APPLICATIONS**

- Power Supply
- Lighting
- Industrial



N-Channel MOSFET

# TO-263 G D S

Ordering Information: SUM33N20-60P-E3 (Lead (Pb)-free)

ABSOLUTE MAXIMUM RATINGS	T <sub>C</sub> = 25 °C, unless ot	herwise noted		
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V <sub>DS</sub>	200	V	
Gate-Source Voltage	V <sub>GS</sub>	± 25	<b>□</b>	
Continuous Drain Current (T <sub>J</sub> = 175 °C)	T <sub>C</sub> = 25 °C	I-	33	
	T <sub>C</sub> = 100 °C	I <sub>D</sub>	20.8	
Pulsed Drain Current	I <sub>DM</sub>	80	_ A	
Single Pulse Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	20	
Single Pulse Avalanche Energy <sup>a</sup>	L = 0.111111	E <sub>AS</sub>	20	mJ
Maximum Power Dissipation <sup>a</sup>	T <sub>C</sub> = 25 °C	В	156 <sup>b</sup>	144
	T <sub>A</sub> = 25 °C <sup>c</sup>	P <sub>D</sub>	3.12	W
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 175	°C

THERMAL RESISTANCE RATINGS				
Parameter	Symbol	Limit	Unit	
Junction-to-Ambient (PCB Mount) <sup>c</sup>	R <sub>thJA</sub>	40	°C/W	
Junction-to-Case (Drain)	R <sub>thJC</sub>	0.8	G/VV	

### Notes:

- a. Duty cycle  $\leq$  1 %.
- b. See SOA curve for voltage derating.
- c. When Mounted on 1" square PCB (FR-4 material).

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Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
Static						
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{DS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$	200			V
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2.5		4.5	
Gate-Body Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
		$V_{DS} = 0 \text{ V}, V_{GS} = \pm 25 \text{ V}$			± 300	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 200 V, V <sub>GS</sub> = 0 V			1	μΑ
		V <sub>DS</sub> = 200 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 100 °C			25	
		V <sub>DS</sub> = 200 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C			250	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 10 \text{ V}, V_{GS} = 10 \text{ V}$	40			Α
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A		0.049	0.060	Ω
		V <sub>GS</sub> = 15 V, I <sub>D</sub> = 20 A		0.0485	0.059	
Drain-Source On-State Resistance <sup>a</sup>	r <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A, T <sub>J</sub> = 100 °C			0.110	
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A, T <sub>J</sub> = 150 °C			0.144	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 20 A	25			S
Dynamic <sup>b</sup>	<u> </u>					
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 25 V, f = 1 MHz		2735		pF
Output Capacitance	C <sub>oss</sub>			271		
Reverse Transfer Capacitance	C <sub>rss</sub>			117		
Tatal Oats Observe G		$V_{DS} = 100 \text{ V}, V_{GS} = 15 \text{ V}, I_D = 50 \text{ A}$		75	113	
Total Gate Charge <sup>c</sup>	$Q_g$			53	80	nC
Gate-Source Charge <sup>c</sup>	$Q_{gs}$	$V_{DS} = 100 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 50 \text{ A}$		14		nC
Gate-Drain Charge <sup>c</sup>	Q <sub>gd</sub>			17.5		
Gate Resistance	$R_{g}$	f = 1 MHz		1.2	1.8	Ω
Turn-On Delay Time <sup>c</sup>	t <sub>d(on)</sub>			16	25	ns ns
Rise Time <sup>c</sup>	t <sub>r</sub>	$V_{DD} = 100 \text{ V}, R_{L} = 2 \Omega$		170	260	
Turn-Off Delay Time <sup>c</sup>	t <sub>d(off)</sub>	$I_D \cong 50 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		26	40	
Fall Time <sup>c</sup>	t <sub>f</sub>			9	18	
Source-Drain Diode Ratings and Cha	aracteristics	(T <sub>C</sub> = 25 °C) <sup>b</sup>				
Continuous Current	I <sub>S</sub>				33	^
Pulsed Current	I <sub>SM</sub>				80	Α
Forward Voltage <sup>a</sup>	V <sub>SD</sub>	I <sub>F</sub> = 20 A, V <sub>GS</sub> = 0 V		0.86	1.5	V
Reverse Recovery Time	t <sub>rr</sub>			114	170	ns
Peak Reverse Recovery Current	I <sub>RM(REC)</sub>			8	12	Α
Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = 40 A, di/dt = 100 A/μs		0.46	0.69	μC
Reverse Recovery Fall Time	t <sub>a</sub>			82		nS
Reverse Recovery Rise Time	t <sub>b</sub>			32		

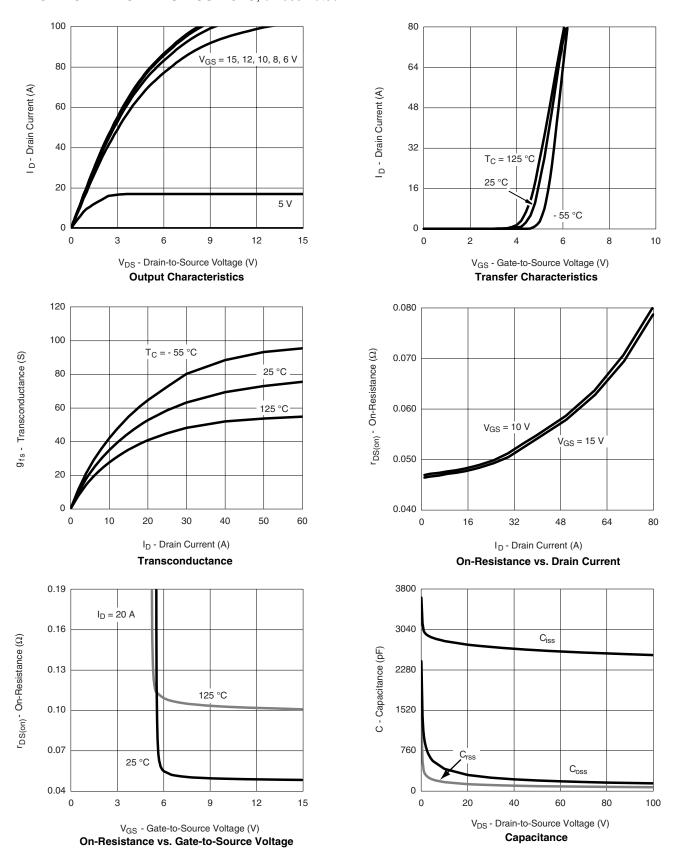
### Notes:

- a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %.
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

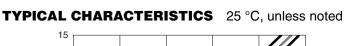
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

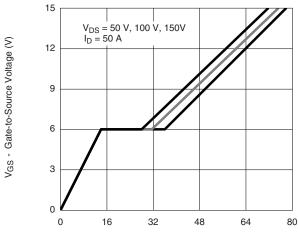


### TYPICAL CHARACTERISTICS 25 °C, unless noted

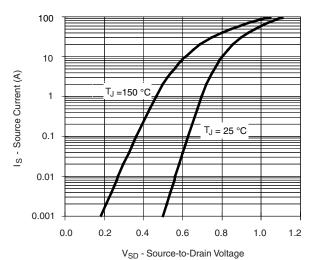


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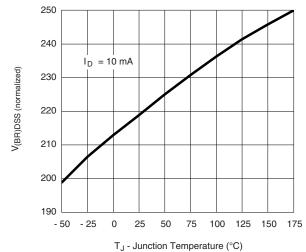




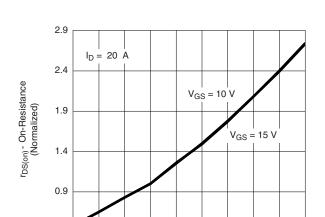
Q<sub>q</sub> - Total Gate Charge (nC) **Gate Charge** 



Source-Drain Diode Forward Voltage



Drain Source Breakdown vs. Junction Temperature



25 50

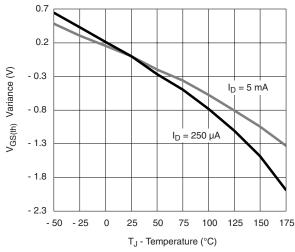
0.4

- 50 - 25

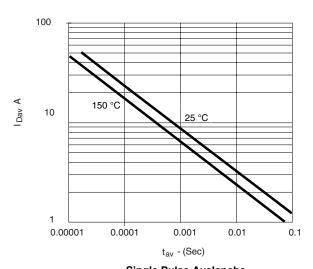
T<sub>.1</sub> - Junction Temperature (°C) On-Resistance vs. Junction Temperature

75

100 125 150



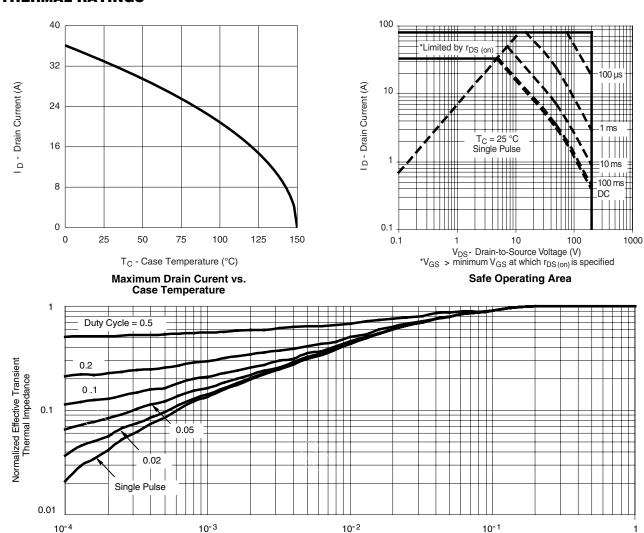
**Threshold Voltage** 



Single Pulse Avalanche Current Capability vs. Time



### THERMAL RATINGS



Square Wave Pulse Duration (sec)

Normalized Thermal Transient Impedance, Junction-to-Case

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see <a href="http://www.vishay.com/ppg?74291">http://www.vishay.com/ppg?74291</a>



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